

February 2007

FDMS8672S

N-Channel PowerTrench[®] SyncFETTM 30V, 35A, $5m\Omega$

Features

- Max $r_{DS(on)}$ = 5.0m Ω at V_{GS} = 10V, I_D = 17A
- Max $r_{DS(on)}$ = 7.0m Ω at V_{GS} = 4.5V, I_D = 15A
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- SyncFET Schottky Body Diode
- MSL1 robust package design
- RoHS Compliant

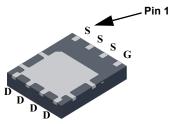


General Description

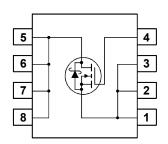
The FDMS8672S has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{\text{DS}(\text{on})}$ while maintaining excellent switching performance. This device has the added benefit of an efficient monolithic Schottky body diode.

Application

- Synchronous Rectifier for DC/DC Converters
- Notebook Vcore/ GPU low side switch
- Networking Point of Load low side switch
- Telecom secondary side rectification



Power 56 (Bottom view)



MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter	Parameter			Units	
V _{DS}	Drain to Source Voltage			30	V	
V _{GS}	Gate to Source Voltage			±20	V	
	Drain Current -Continuous (Package limited)	T _C = 25°C		35		
I _D	-Continuous (Silicon limited)	T _C = 25°C		90		
	-Continuous	T _A = 25°C		17	_ A	
	-Pulsed			200		
D	Power Dissipation			50	W	
P _D Power Dissipation		T _A = 25°C	(Note 1a)	2.5	VV	
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C	

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case		2.5	°C/W
$R_{\theta,JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS8672S	FDMS8672S	Power 56	13"	12mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 1mA$, $V_{GS} = 0V$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 50mA, referenced to 25°C		23		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24V, V _{GS} = 0V			500	μА
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1mA$	1	1.5	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 50mA, referenced to 25°C		-5.4		mV/°C
		V _{GS} = 10V, I _D = 17A		4.0	5.0	
r _{DS(on)}	r _{DS(on)} Drain to Source On Resistance	$V_{GS} = 4.5V, I_D = 15A$		5.2	7.0	mΩ
	$V_{GS} = 10V$, $I_D = 17A$, $T_J = 125$ °C		6.1	7.8		
g _{FS}	Forward Transconductance	$V_{DS} = 10V, I_{D} = 17A$		72		S

Dynamic Characteristics

C _{iss}	Input Capacitance	\\ -15\\\\\ -0\\		1890	2515	pF
C _{oss}	Output Capacitance	V _{DS} = 15V, V _{GS} = 0V f = 1MHz		555	740	pF
C _{rss}	Reverse Transfer Capacitance	I - IIVII IZ		205	380	pF
R_g	Gate Resistance	f = 1MHz		1.1		Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		V_{DD} = 15V, I_{D} = 17A V_{GS} = 10V, R_{GEN} = 7 Ω		11	20	ns
t _r	Rise Time	V _{DD} = 15V, I _D = 17			17	31	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} = 10V, K _{GEN}			27	44	ns
t _f	Fall Time				7	14	ns
$Q_{g(TOT)}$	Total Gate Charge at 10V	V _{GS} = 0V to 10V			33	47	nC
Q _{g(4.5V)}	Total Gate Charge at 4.5V	$V_{GS} = 0V \text{ to } 4.5V$	V _{DD} = 15V,		16	23	nC
Q _{gs}	Gate to Source Gate Charge		I _D = 17A		5		nC
Q _{gd}	Gate to Drain "Miller" Charge				6		nC

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0V, I _S = 1.7A	0.4	0.7	V
t _{rr}	Reverse Recovery Time	I _F = 17A, di/dt = 300A/μs	20	32	ns
Q _{rr}	Reverse Recovery Charge	1F - 17A, αι/αι - 300A/μs	16	28	nC

Notes: 1. $R_{\theta,JA}$ is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



a. 50°C/W when mounted on a 1 in² pad of 2 oz copper

b. 125°C/W when mounted on a minimum pad of 2 oz copper



2: Pulse time < 300 μ s, Duty cycle < 2.0%.

Typical Characteristics T_J = 25°C unless otherwise noted

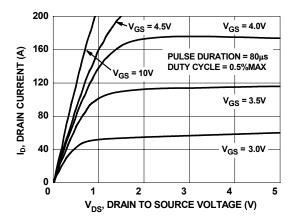


Figure 1. On Region Characteristics

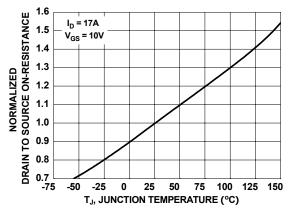


Figure 3. Normalized On Resistance vs Junction Temperature

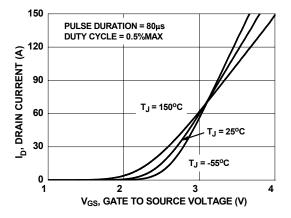


Figure 5. Transfer Characteristics

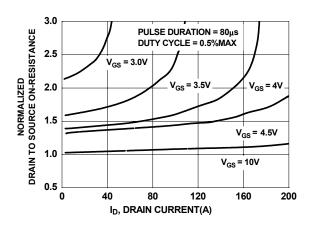


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

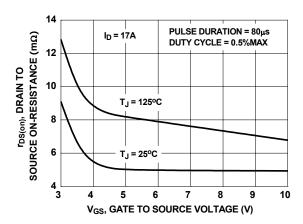


Figure 4. On-Resistance vs Gate to Source Voltage

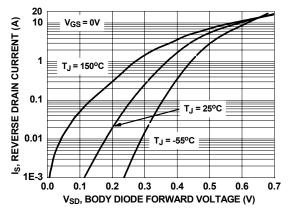


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25°C unless otherwise noted

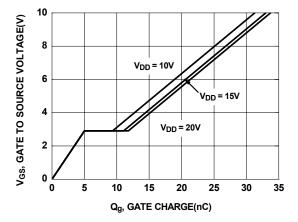


Figure 7. Gate Charge Characteristics

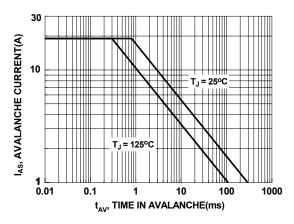


Figure 9. Unclamped Inductive Switching Capability

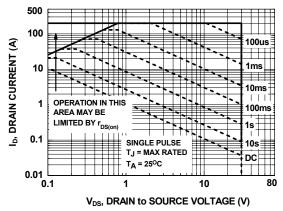


Figure 11. Forward Bias Safe Operating Area

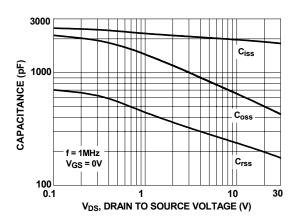


Figure 8. Capacitance vs Drain to Source Voltage

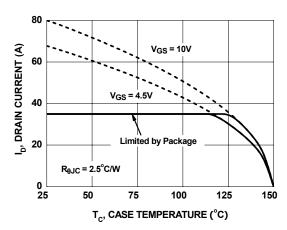


Figure 10. Maximum Continuous Drain Current vs Case Temperature

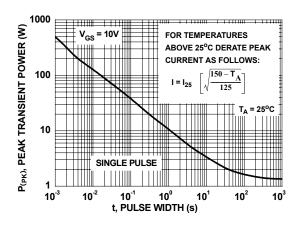


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25°C unless otherwise noted

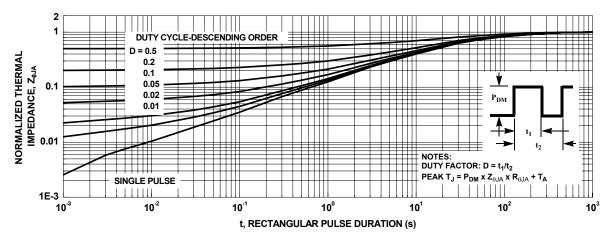


Figure 13. Transient Thermal Response Curve

Typical Characteristics (continued)

SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MoSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverses recovery characteristic of the FDMS8672S.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

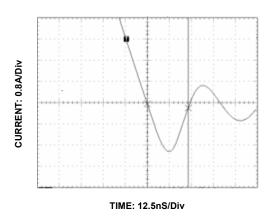


Figure 14. FDMS8672S SyncFET Body Diode Reverse Recovery Characteristics

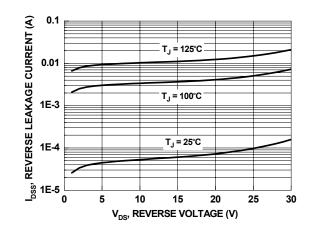
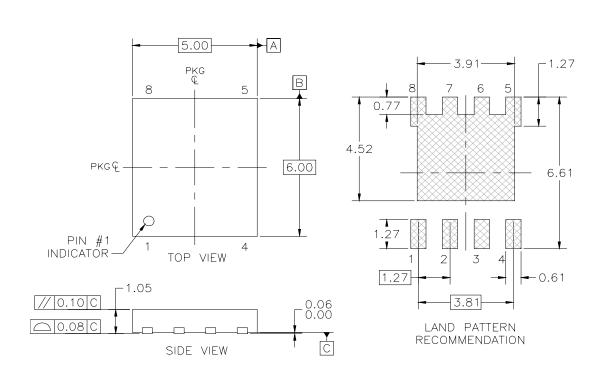
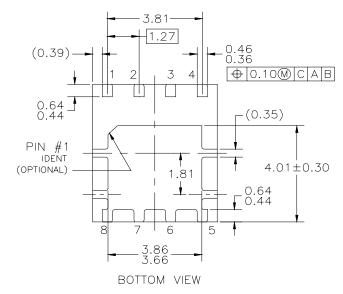


Figure 15. SyncFET Body Diode Reverse Leakage vs Drain to Source Voltage





NOTES: UNLESS OTHERWISE SPECIFIED

- ALL DIMENSIONS ARE IN MILLIMETERS.
- NO JEDEC REFERENCE AS OF FEBRUARY 2006 DIMENSIONING AND TOLERANCING PER ASME Y14.5M 1994

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